Notice of References Cited Application/Control No. 10/595,112 Examiner Tianjie Chen Applicant(s)/Patent Under Reexamination KONDOU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,991,048	02-1991	Ikebe et al.	360/133
*	В	US-2006/0143642 A1	06-2006	Kawasaki et al.	720/738
*	С	US-2006/0095934 A1	05-2006	Kobayashi et al.	720/738
*	D	US-2001/0014079	08-2001	Kikuchi et al.	369/291
*	Е	US-2001/0014078	08-2001	Sawada et al.	369/291
*	F	US-6,212,038 B1	04-2001	Kishida, Hiroshi	360/133
*	G	US-5,793,742	08-1998	Sandell et al.	720/734
*	Ι	US-6,157,517 A	12-2000	Kishida, Hiroshi	360/133
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.